

COMPLIANT



High-Speed, Low-Glitch D/CMOS Analog Switches

DESCRIPTION

The DG611, DG612, DG613 feature high-speed low-capacitance lateral DMOS switches. Charge injection has been minimized to optimize performance in fast sample-and-hold applications.

Each switch conducts equally well in both directions when on and blocks up to 16 V_{p-p} when off. Capacitances have been minimized to ensure fast switching and low-glitch energy. To achieve such fast and clean switching performance, the DG611, DG612, DG613 are built on the Vishay Siliconix proprietary D/CMOS process. This process combines n-channel DMOS switching FETs with low-power CMOS control logic and drivers. An epitaxial layer prevents latchup.

The DG611 and DG612 differ only in that they respond to opposite logic levels. The versatile DG613 has two normally open and two normally closed switches. It can be given various configurations, including four SPST, two SPDT, one DPDT.

For additional information see Applications Note AN207.

FEATURES

Fast switching - t_{ON}: 12 ns
 Low charge injection: ± 2 pC

Wide bandwidth: 500 MHz5 V CMOS logic compatible

Low R_{DS(on)}: 18 Ω

Low quiescent power : 1.2 nW

Single supply operation

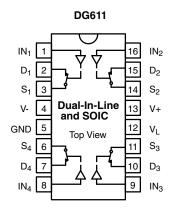
BENEFITS

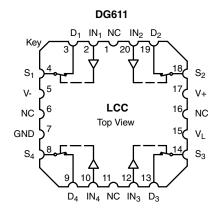
- · Improved data throughput
- · Minimal switching transients
- Improved system performance
- · Easily interfaced
- Low insertion loss
- · Minimal power consumption

APPLICATIONS

- Fast sample-and-holds
- · Synchronous demodulators
- · Pixel-rate video switching
- · Disk/tape drives
- DAC deglitching
- · Switched capacitor filters
- GaAs FET drivers
- · Satellite receivers

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION





Four SPST Switches per Package

| TRUTH TABLE | | | | | |
|-------------|-------|-------|--|--|--|
| Logic | DG611 | DG612 | | | |
| 0 | ON | OFF | | | |
| 1 | OFF | ON | | | |

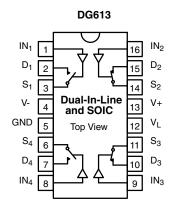
Logic "0" ≤ 1 V Logic "1" ≥ 4 V

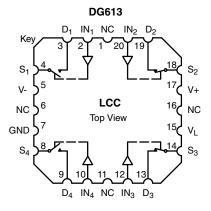
Document Number: 70057 S11-0154-Rev. I, 31-Jan-11

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION





Four SPST Switches per Package

| TRUTH TABLE | | | | | |
|-------------|-----------------------------------|-----------------------------------|--|--|--|
| Logic | SW ₁ , SW ₄ | SW ₂ , SW ₃ | | | |
| 0 | OFF | ON | | | |
| 1 | ON | OFF | | | |

 $\begin{array}{l} \text{Logic "0"} \leq 1 \text{ V} \\ \text{Logic "1"} \geq 4 \text{ V} \end{array}$

| ORDERING INFORMATION | | | | | | |
|----------------------|---------------------|--|--|--|--|--|
| Temp. Range | Package | Part Number | | | | |
| DG611, DG612 | · | | | | | |
| | 16-Pin Plastic DIP | DG611DJ DG611DJ-E3 | | | | |
| | 10-FIII Flastic DIF | DG612DJ DG612DJ-E3 | | | | |
| - 40 °C to 85 °C | 46 Bio Navious COIG | DG611DY DG611DY-E3 DG611DY-T1 DG611DY-T1-E3 | | | | |
| | 16-Pin Narrow SOIC | DG612DY DG612DY-E3 DG612DY-T1 DG612DY-T1-E3 | | | | |
| DG613 | · | | | | | |
| - 40 °C to 85 °C | 16-Pin Plastic DIP | DG613DJ DG613DJ-E3 | | | | |
| | 16-Pin Narrow SOIC | DG613DY DG613DY-E3 DG613DY-T1 DG613DY-T1-E3 | | | | |



| ABSOLUTE MAXIMUM | I RATINGS | | | | |
|---|---------------------------------|----------------------------------|-------|--|--|
| Parameter | | Limit | Unit | | |
| V+ to V- | | - 0.3 to 21 | | | |
| V+ to GND | | - 0.3 to 21 | | | |
| V- to GND | | - 19 to 0.3 | | | |
| V _I to GND | | - 1 to (V+) + 1 | ., | | |
| VE TO GIVE | | or 20 mA, whichever occurs first | V | | |
| $V_{IN}{}^a$ | | (V-) - 1 to (V+) + 1 | | | |
| | | or 20 mA, whichever occurs first | | | |
| V_S, V_D^a | | (V-) - 0.3 to (V+) + 16 | | | |
| | | or 20 mA, whichever occurs first | | | |
| Continuous Current (Any Terminal) | | ± 30 | mA | | |
| Current, S or D (Pulsed at 1 µs, 10 % Duty Cycle) | | ± 100 | | | |
| Ctorogo Tomporatura | CerDIP | - 65 to 150 | °C | | |
| Storage Temperature | Plastic | - 65 to 125 |) | | |
| | 16-Pin Plastic DIP ^c | 470 | | | |
| Power Dissipation (Package) ^b | 16-Pin Narrow SOIC ^d | 600 | mW | | |
| | 16-Pin CerDIP ^e | 900 | 11100 | | |
| | 20-Pin LCC ^e | 900 | | | |

Notes

- $a. \ Signals \ on \ S_X, \ D_X, \ or \ IN_X \ exceeding \ V+ \ or \ V- \ will \ be \ clamped \ by \ internal \ diodes. \ Limit \ forward \ diode \ current \ to \ maximum \ current \ ratings.$
- b. All leads welded or soldered to PC board.
- c. Derate 6 mW/°C above 75 °C.
- d. Derate 7.6 mW/°C above 75 °C.
- e. Derate 12 mW/°C above 75 °C.

| RECOMMENDED OPERATING RANGE | | | | | |
|-----------------------------|---------------------|------|--|--|--|
| Parameter | Limit | Unit | | | |
| V+ | 5 to 21 | | | | |
| V- | - 10 to 0 | | | | |
| V _L | 4 to V+ | V | | | |
| V _{IN} | 0 to V _L | | | | |
| V _{ANALOG} | V- to (V+) - 5 | | | | |

DG611, DG612, DG613

Vishay Siliconix



| | Test Conditions Unless Otherwise Specific | | | | A Suffix | | D Suffix - 40 °C to 85 °C | | |
|-------------------------------------|---|--|--------------|-------------------|----------------|------------|------------------------------|------------|------|
| Parameter | Symbol | V+ = 15 V, V- = - 3 V V _L = 5 V, V _{IN} = 4 V, 1 V ^f | Temp.b | Typ. ^c | Min.d | Max.d | Min.d | Max.d | Unit |
| Analog Switch | 1 -, | L - 7 IIN 7 | | _ , , , | | | | | |
| Analog Signal Range ^e | V _{ANALOG} | V- = - 5 V, V+ = 12 V | Full | | - 5 | 7 | - 5 | 7 | V |
| Switch On-Resistance | R _{DS(on)} | I _S = - 1 mA, V _D = 0 V | Room Full | 18 | | 45 60 | | 45 60 | Ω |
| Resistance Match Bet Ch. | $\Delta R_{DS(on)}$ | | Room | 2 | | | | | . 32 |
| Source Off Leakage | I _{S(off)} | V _S = 0 V, V _D = 10 V | Room Hot | ± 0.001 | - 0.25 - 20 | 0.25 20 | - 0.25 - 20 | 0.25 20 | |
| Drain Off Leakage Current | I _{D(off)} | V _S = 10 V, V _D = 0 V | Room Hot | ± 0.001 | - 0.25 - 20 | 0.25 20 | - 0.25 - 20 | 0.25 20 | nA |
| Switch On Leakage Current | I _{D(on)} | V _S = V _D = 0 V | Room Hot | ± 0.001 | - 0.4 - 40 | 0.4 40 | - 0.4 - 40 | 0.4 40 | |
| Digital Control | | | | | | | | | |
| Input Voltage High | V _{IH} | | Full | | 4 | | 4 | | V |
| Input Voltage Low | V _{IL} | | Full | | | 1 | | 1 | ľ |
| Input Current | I _{IN} | | Room Hot | 0.005 | - 1 - 20 | 1 20 | - 1 - 20 | 1 20 | μΑ |
| Input Capacitance | C _{IN} | | Room | 5 | | | | | pF |
| Dynamic Characteristics | | | | | | | | | |
| Off State Input Capacitance | C _{S(off)} | V _S = 0 V | Room | 3 | | | | | |
| Off State Output Capacitance | C _{D(off)} | V _D = 0 V | Room | 2 | | | | | pF |
| On State Input Capacitance | C _{S(on)} | $V_S = V_D = 0 V$ | Room | 10 | | | | | |
| Bandwidth | BW | $R_L = 50 \Omega$ | Room | 500 | | | | | MHz |
| Turn-On Time ^e | t _{ON} | $R_L = 300 \Omega, C_L = 3 pF$ | Room | 12 | | 25 | | 25 | |
| Turn-Off Time ^e | t _{OFF} | $V_S = \pm 2 \text{ V},$ See test circuit, figure 2 | Room | 8 | | 20 | | 20 | |
| Turn-On Time | t _{ON} | $R_L = 300 \Omega, C_L = 75 pF$ $V_S = \pm 2 V,$ | Room Full | 19 | | 35 50 | | 35 50 | ns |
| Turn-Off Time | t _{OFF} | See test circuit, figure 2 | Room Full | 16 | | 25 35 | | 25 35 | |
| Charge Injection ^e | Q | $C_L = 1 \text{ nF, } V_S = 0 \text{ V}$ | Room | 4 | | | | | рС |
| Ch. Injection Change ^{e,g} | ΔQ | $C_L = 1 \text{ nF}, V_S \leq 3 \text{ V}$ | Room | 3 | | 4 | | 4 | рО |
| Off Isolation ^e | OIRR | $R_{IN} = 50 \Omega, R_{L} = 50 \Omega$ f = 5 MHz | Room | 74 | | | | | dB |
| Crosstalk ^e | X _{TALK} | $R_{IN} = 10 \Omega, R_{L} = 50 \Omega$ f = 5 MHz | Room | 87 | | | | | aB |
| Power Supplies | | | | | | | | | |
| Positive Supply Current | l+ | | Room Full | 0.005 | | 1 5 | | 1 5 | |
| Negative Supply Current | l- | V _{IN} = 0 V or 5 V | Room Full | - 0.005 | - 1 - 5 | | - 1 - 5 | | μΑ |
| Logic Supply Current | Ι <u>L</u> | NIN - 0 4 01 2 4 | Room Full | 0.005 | | 1 5 | | 1 5 | μΑ |
| Ground Current | I _{GND} | | Room Full | - 0.005 | - 1 - 5 | | - 1 - 5 | | |



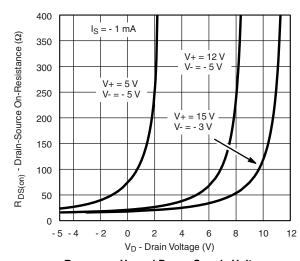
| SPECIFICATIONS FOR UNIPOLAR SUPPLIES ^a | | | | | | | | | |
|---|---------------------|--|--------|-------------------|-------------------------------|-------------------|-------------------------------------|-------|------|
| | | Test Conditions Unless Otherwise Specified | | | A Suffix - 55 °C to 125 °C | | D Suffix - 40 °C to 85 °C | | |
| Parameter | Symbol | V+ = 15 V, V- = -3 V $V_L = 5 V, V_{IN} = 4 V, 1 V^f$ | Temp.b | Ty.p ^c | Min.d | Max. ^d | Min.d | Max.d | Unit |
| Analog Switch | | | | | | | | | |
| Analog Signal Range ^e | V _{ANALOG} | | Full | | 0 | 7 | 0 | 7 | V |
| Switch On-Resistance | R _{DS(on)} | I _S = - 1 mA, V _D = 1 V | Room | 25 | | 60 | | 60 | Ω |
| Dynamic Characteristics | | | | | | | | | |
| Turn-On Time ^e | t _{ON} | $R_L = 300 \Omega, C_L = 3 pF$ | Room | 15 | | 30 | | 30 | |
| Turn-Off Time ^e | t _{OFF} | $V_S = 2 V$, See test circuit, figure 2 | Room | 10 | | 25 | | 25 | ns |

Notes:

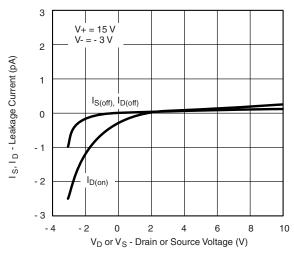
- a. Refer to PROCESS OPTION FLOWCHART.
- b. Room = 25 °C, Full = as determined by the operating temperature suffix.
- c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum.
- e. Guaranteed by design, not subject to production test.
- f. V_{IN} = input voltage to perform proper function. g. $\Delta Q = |Q|$ at $V_S = 3 V Q$ at $V_S = -3 V|$.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



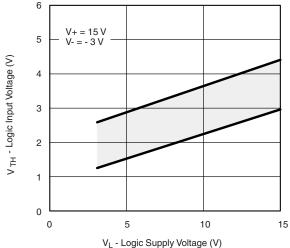
 $R_{DS(on)}$ vs. V_D and Power Supply Voltages



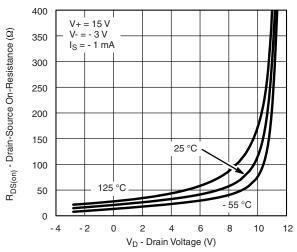
Leakage Current vs. Analog Voltage

VISHAY

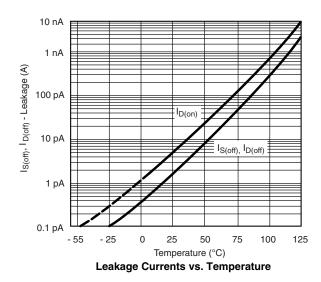
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Input Switching Threshold vs. V_L

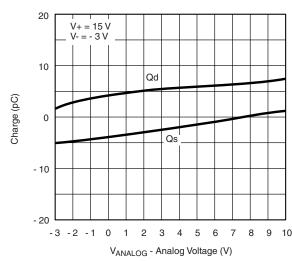


 $R_{DS(on)}$ vs. V_D and Temperature

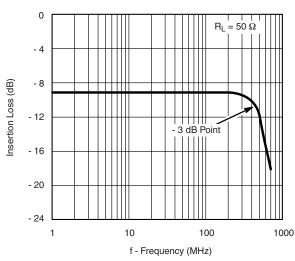


24 22 20 18 t_{ON} 16 14 Time (ns) toff 12 10 8 6 V- = - 3 V 4 $R_L = 300 \ \Omega$ $C_{L} = 10 \text{ pF}$ 2 0 - 35 - 15 5 25 45 65 85 105 125 - 55 Temperature (°C)

Switching Times vs. Temperature



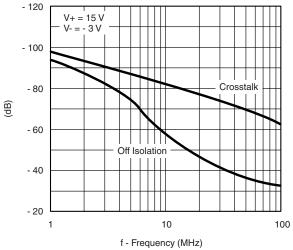
Charge Injection vs. Analog Voltage



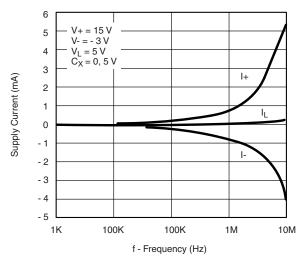
- 3 dB Bandwidth/Insertion Loss vs. Frequency



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Crosstalk and Off Isolation vs. Frequency



Supply Currents vs. Switching Frequency

SCHEMATIC DIAGRAM (Typical Channel)

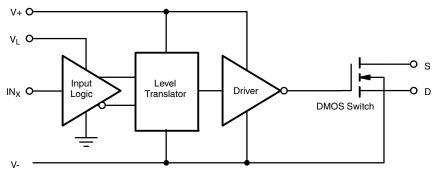
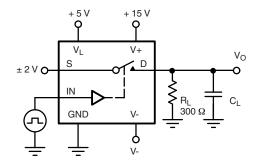
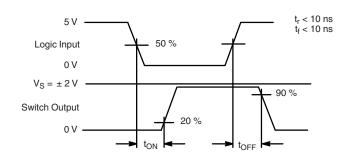


Figure 1.

TEST CIRCUITS





C_L (includes fixture and stray capacitance)

 $V_O = V_S$ $\frac{R_L}{R_L + r_{DS(on)}}$

Figure 2. Switching Time

TEST CIRCUITS



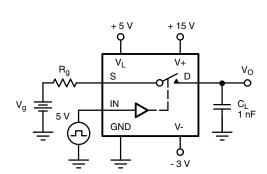


Figure 3. Charge Injection

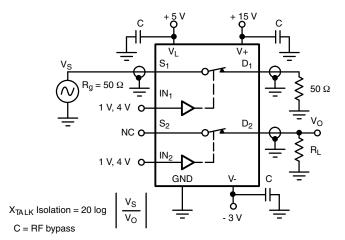


Figure 4. Crosstalk

APPLICATIONS

High-Speed Sample-and-Hold

In a fast sample-and-hold application, the analog switch characteristics are critical. A fast switch reduces aperture uncertainty. A low charge injection eliminates offset (step) errors. A low leakage reduces droop errors. The CLC111, a fast input buffer, helps to shorten acquisition and settling times. A low leakage, low dielectric absorption hold capacitor must be used. Polycarbonate, polystyrene and polypropylene are good choices. The JFET output buffer reduces droop due to its low input bias current. (see figure 5.)

Pixel-Rate Switch

Windows, picture-in-picture, title overlays are economically generated using a high-speed analog switch such as the DG613. For this application the two video sources must be sync locked. The glitch-less analog switch eliminates halos. (see figure 6.)

GaAs FET Drivers

Figure 7 illustrates a high-speed GaAs FET driver. To turn the GaAs FET on 0 V are applied to its gate via S_1 , whereas to turn it off, - 8 V are applied via S_2 . This high-speed, low-power driver is especially suited for applications that require a large number of RF switches, such as phased array radars.

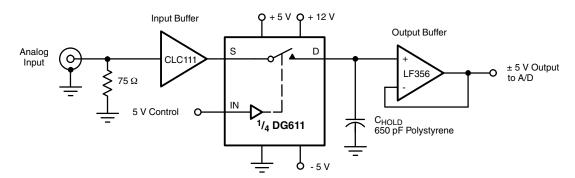


Figure 5. High-Speed Sample-and-Hold



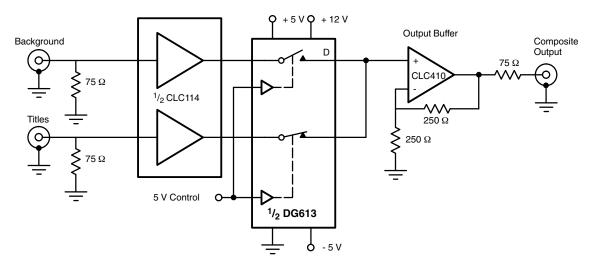


Figure 6. A Pixel-Rate Switch Creates Title Overlays

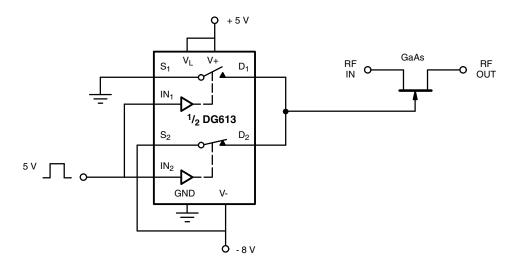


Figure 7. A High-Speed GaAs FET Driver that Saves Power

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Document Number: 91000 www.vishay.com
Revision: 11-Mar-11 1